SWITCHMODE MPN **Bipolar Power Transistor**

For Switching Power Supply Applications

The BUL146G / BUL146FG have an applications specific state-of-the-art die designed for use in fluorescent electric lamp ballasts to 130 W and in Switchmode Power supplies for all types of electronic equipment.

Features

- Improved Efficiency Due to Low Base Drive Requirements:
 - High and Flat DC Current Gain
 - Fast Switching
 - No Coil Required in Base Circuit for Turn-Off (No Current Tail)
- Full Characterization at 125°C
- Two Packages Choices: Standard TO-220 or Isolated TO-220
- Parametric Distributions are Tight and Consistent Lot-to-Lot
- $\bullet\,$ BUL146F, Case 221D, is UL Recognized to 3500 $V_{RMS}\!:$ File # E69369
- These Devices are Pb-Free and are RoHS Compliant*

MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|--|--|--|-----------|
| Collector-Emitter Sustaining Voltage | V_{CEO} | 400 | Vdc |
| Collector-Base Breakdown Voltage | V _{CES} | 700 | Vdc |
| Emitter-Base Voltage | V _{EBO} | 9.0 | Vdc |
| Collector Current – Continuous – Peak (Note 1) | I _C | 6.0 15 | Adc |
| Base Current – Continuous – Peak (Note 1) | I _B | 4.0 8.0 | Adc |
| RMS Isolation Voltage (Note 2) (for 1 sec, R.H. < 30%, T _C = 25°C) | V _{ISOL1} V _{ISOL2} V _{ISOL3} | BUL146F 4500 3500 1500 | ٧ |
| Total Device Dissipation @ T _C = 25°C BUL146 BUL146F Derate above 25°C BUL146F BUL146F | P _D | 100 40 0.8 0.32 | W W/°C |
| Operating and Storage Temperature | T _J , T _{stg} | -65 to 150 | °C |

THERMAL CHARACTERISTICS

| Characteristics | Symbol | Max | Unit |
|--|-----------------|---------------|------|
| Thermal Resistance, Junction-to-Case BUL146 BUL146F | $R_{	heta JC}$ | 1.25 3.125 | °C/W |
| Thermal Resistance, Junction-to-Ambient | $R_{\theta JA}$ | 62.5 | °C/W |
| Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 5 Seconds | T_L | 260 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Pulse Test: Pulse Width = 5 ms, Duty Cycle ≤ 10%.
- 2. Proper strike and creepage distance must be provided.

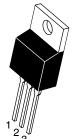


ON Semiconductor®

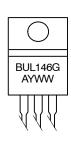
http://onsemi.com

POWER TRANSISTOR 8.0 AMPERES 1000 VOLTS 45 and 125 WATTS

MARKING DIAGRAMS

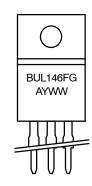


TO-220AB CASE 221A-09 STYLE 1





TO-220 FULLPACK CASE 221D STYLE 2 UL RECOGNIZED



G = Pb-Free Package A = Assembly Location

Y = Year WW = Work Week

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

| Characteristic | | | | Symbol | Min | Тур | Max | Unit |
|--|---|-------------------------|--------------------------|-----------------------|--------|--------------|-------------|-------|
| OFF CHARACTERISTICS | | | | | | | | |
| Collector–Emitter Sustaining Voltage (I _C = 100 mA, L = 25 mH) | | | | V _{CEO(sus)} | 400 | - | - | Vdc |
| Collector Cutoff Current (V _{CE} = | Rated V _{CEO} , I _B = 0 |) | | I _{CEO} | - | - | 100 | μAdc |
| Collector Cutoff Current (V _{CE} = | | : 0) | (T _C = 125°C) | I _{CES} | - - | _ _ | 100 500 | μAdc |
| (0.0 | = 500 V, V _{EB} = 0) | | (T _C = 125°C) | | _ | - | 100 | A -1- |
| Emitter Cutoff Current (V _{EB} = 9 | 0.0 Vdc, I _C = 0) | | | I _{EBO} | - | _ | 100 | μAdc |
| ON CHARACTERISTICS | | | | | i | 1 | | |
| Base-Emitter Saturation Voltag | ge ($I_C = 1.3 \text{ Adc}, I_E$ ($I_C = 3.0 \text{ Adc}, I_E$ | , | , | V _{BE(sat)} | _ _ | 0.82 0.93 | 1.1 1.25 | Vdc |
| Collector-Emitter Saturation Vo | oltage (I _C = 1.3 Ad | c, I _B = 0. | 13 Adc) | V _{CE(sat)} | - | 0.22 | 0.5 | Vdc |
| | | | $(T_C = 125^{\circ}C)$ | | - | 0.20 | 0.5 | |
| | $(I_C = 3.0 \text{ Ad})$ | c, I _B = 0.6 | • | | - | 0.30 | 0.7 | |
| | | | (T _C = 125°C) | | - | 0.30 | 0.7 | |
| DC Current Gain (I _C = 0.5 Ad | c, V _{CE} = 5.0 Vdc) | | | h _{FE} | 14 | - | 34 | - |
| | | | $(T_C = 125^{\circ}C)$ | | - | 30 | - | |
| $(I_C = 1.3 \text{ Ad})$ | c, V _{CE} = 1.0 Vdc) | | | | 12 | 20 | - | |
| | | | $(T_C = 125^{\circ}C)$ | | 12 | 20 | - | |
| (I _C = 3.0 Ad | c, V _{CE} = 1.0 Vdc) | | (T. 15-00) | | 8.0 | 13 | - | |
| $(T_C = 125^{\circ}C)$ | | | | | 7.0 | 12 | _ | |
| (I _C = 10 mA | dc , $V_{CE} = 5.0 \text{ Vdc}$ | | | | 10 | 20 | _ | |
| DYNAMIC CHARACTERISTICS | | | | | | | | |
| Current Gain Bandwidth ($I_C = 0$ | 0.5 Adc, $V_{CE} = 10 \text{ V}_{CE}$ | dc, f = 1.0 | MHz) | f _T | - | 14 | - | MHz |
| Output Capacitance (V _{CB} = 10 | Vdc, $I_E = 0$, $f = 1.0$ | MHz) | | C _{OB} | - | 95 | 150 | pF |
| Input Capacitance (V _{EB} = 8.0 V) | | | | C _{IB} | - | 1000 | 1500 | pF |
| | I _{B1} = 300 mAdc | 1.0 | | | - | 2.5 | - | |
| Dynamic Saturation Voltage: Determined 1.0 μs and 3.0 μs respectively after rising I _{B1} reaches 90% of final I _{B1} (see Figure 18) | | 1.0 μs (T _C | (T _C = 125°C) | | - | 6.5 | - | |
| | | 3.0 μs (T | (T _C = 125°C) | | - | 0.6 | - | |
| | | | | V _{CE(dsat)} | _ | 2.5 | - | V |
| | (I _C = 3.0 Adc 1.0 μs | 1.0 μs | /T 40500\ | ▼ CE(asat) | - | 3.0 | - | • |
| | | | (T _C = 125°C) | | | 7.0 | _ | |
| | | 3.0 μs | (T _C = 125°C) | | - | 0.75 1.4 | - | |

| | Characteristic | | Symbol | Min | Тур | Max | Unit |
|------------------|--|-------------------------------|------------------|----------|--------------|----------|------|
| SWITCHING CHARAC | TERISTICS: Resistive Load (D.C. ≤ | 10%, Pulse Width | = 20 μs) | | I | | |
| Turn-On Time | $(I_C = 1.3 \text{ Adc}, I_{B1} = 0.13 \text{ Adc} $ $I_{B2} = 0.65 \text{ Adc}, V_{CC} = 300 \text{ V})$ | (T _C = 125°C) | t _{on} | _ _ | 100 90 | 200 - | ns |
| Turn-Off Time | | (T _C = 125°C) | t _{off} | - - | 1.35 1.90 | 2.5 - | μs |
| Turn-On Time | (I _C = 3.0 Adc, I _{B1} = 0.6 Adc I _{B1} = 1.5 Adc, V _{CC} = 300 V) | (T _C = 125°C) | t _{on} | - - | 90 100 | 150 - | ns |
| Turn-Off Time | | (T _C = 125°C) | t _{off} | - - | 1.7 2.1 | 2.5 - | μs |
| SWITCHING CHARAC | TERISTICS: Inductive Load (V _{clamp} | = 300 V, V _{CC} = 15 | V, L = 200 μH) | | | | |
| Fall Time | (I _C = 1.3 Adc, I _{B1} = 0.13 Adc I _{B2} = 0.65 Adc) | (T _C = 125°C) | t _{fi} | _ _ | 115 120 | 200 - | ns |
| Storage Time | | (T _C = 125°C) | t _{si} | - - | 1.35 1.75 | 2.5 - | μs |
| Crossover Time | | (T _C = 125°C) | t _c | - - | 200 210 | 350 - | ns |
| Fall Time | $(I_C = 3.0 \text{ Adc}, I_{B1} = 0.6 \text{ Adc} $ $I_{B2} = 1.5 \text{ Adc})$ | (T _C = 125°C) | t _{fi} | - - | 85 100 | 150 - | ns |
| Storage Time | | (T _C = 125°C) | t _{si} | - | 1.75 2.25 | 2.5 - | μs |
| Crossover Time | | (T _C = 125°C) | t _c | - - | 175 200 | 300 | ns |
| Fall Time | $(I_C = 3.0 \text{ Adc}, I_{B1} = 0.6 \text{ Adc} $ $I_{B2} = 0.6 \text{ Adc})$ | (T _C = 125°C) | t _{fi} | 80 - | _ 210 | 180 - | ns |
| Storage Time | | (T _C = 125°C) | t _{si} | 2.6 - | - 4.5 | 3.8 | μS |
| Crossover Time | | (T _C = 125°C) | t _c | _ _ | 230 400 | 350 - | ns |

TYPICAL STATIC CHARACTERISTICS

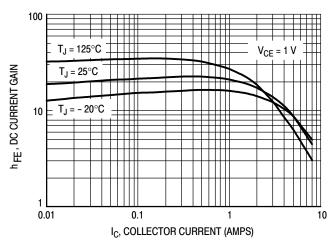


Figure 1. DC Current Gain @ 1 Volt

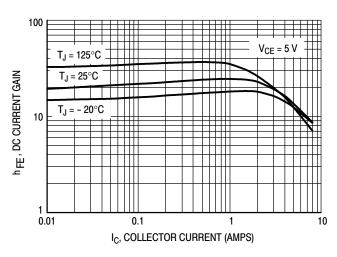


Figure 2. DC Current Gain @ 5 Volts

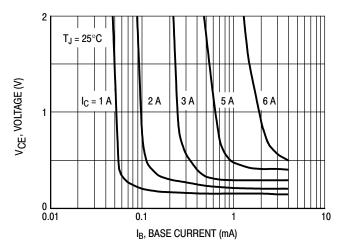


Figure 3. Collector Saturation Region

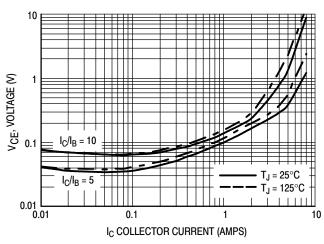


Figure 4. Collector-Emitter Saturation Voltage

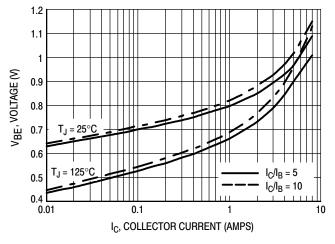


Figure 5. Base-Emitter Saturation Region

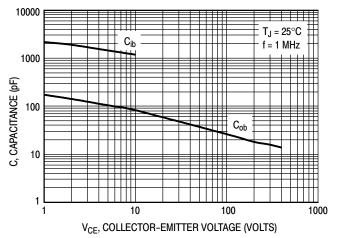
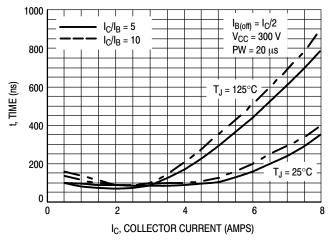


Figure 6. Capacitance

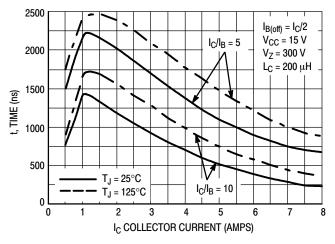
TYPICAL SWITCHING CHARACTERISTICS $(I_{B2} = I_C/2 \text{ for all switching})$



4000 $I_{B(off)} = I_{C}/2$ $T_J = 25^{\circ}C$ $V_{CC} = 300 \text{ V}$ 3500 T_J = 125°C $PW = 20 \; \mu s$ $I_C/I_B = 5$ 3000 2500 t, TIME (ns) $I_C/I_B = 10$ 2000 1500 1000 500 IC, COLLECTOR CURRENT (AMPS)

Figure 7. Resistive Switching, ton

Figure 8. Resistive Switching, toff



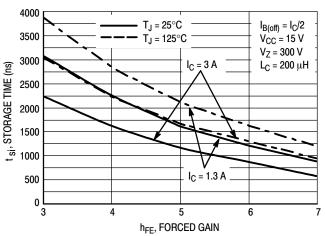
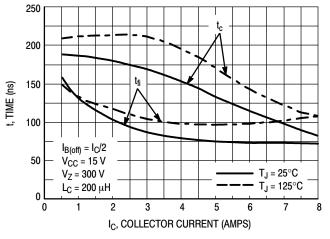


Figure 9. Inductive Storage Time, tsi

Figure 10. Inductive Storage Time, tsi(hFE)



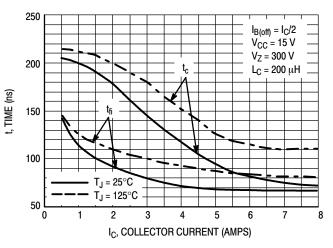
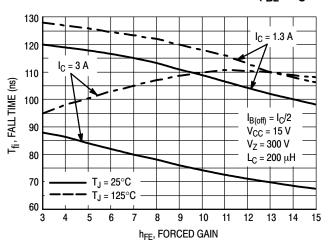


Figure 11. Inductive Switching, t_c and t_{fi} $I_C/I_B=5$

Figure 12. Inductive Switching, t_c and t_{fi} $I_C/I_B=10$

TYPICAL SWITCHING CHARACTERISTICS $(I_{B2} = I_C/2 \text{ for all switching})$



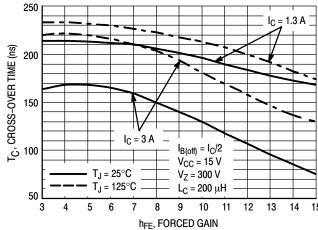
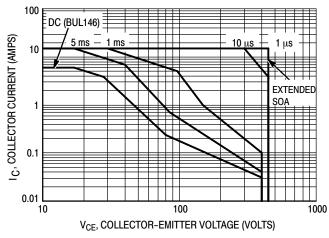


Figure 13. Inductive Fall Time

Figure 14. Inductive Cross-Over Time

GUARANTEED SAFE OPERATING AREA INFORMATION



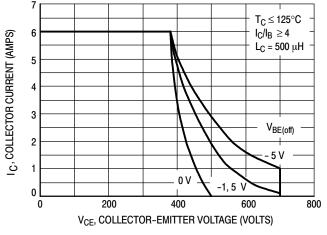


Figure 15. Forward Bias Safe Operating Area

Figure 16. Reverse Bias Switching Safe Operating Area

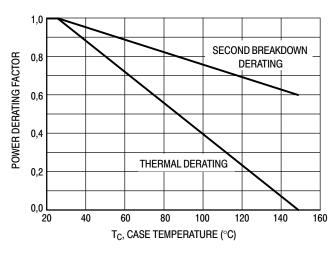
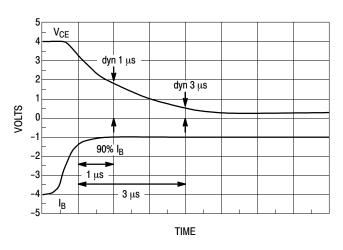


Figure 17. Forward Bias Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C - V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 15 is based on $T_C = 25^{\circ}C$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C > 25$ °C. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown in Figure 15 may be found at any case temperature by using the appropriate curve on Figure 17. T_{J(pk)} may be calculated from the data in Figure 20. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base-to-emitter junction reverse-biased. The safe level is specified as a reversebiased safe operating area (Figure 16). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.



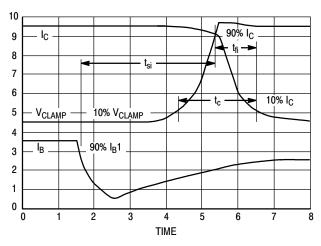


Figure 18. Dynamic Saturation Voltage Measurements

Figure 19. Inductive Switching Measurements

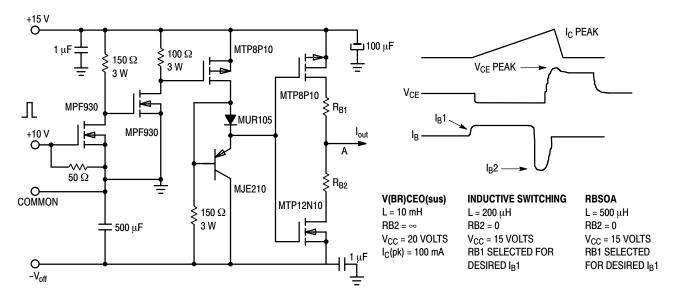


Table 1. Inductive Load Switching Drive Circuit

TYPICAL THERMAL RESPONSE

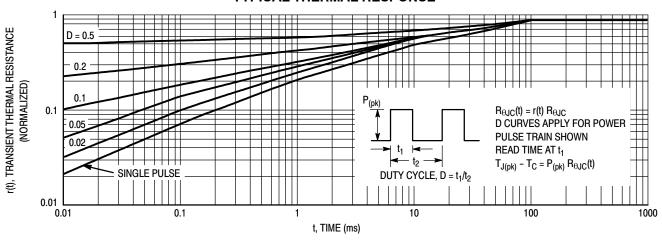


Figure 20. Typical Thermal Response ($Z_{\theta JC}(t)$) for BUL146

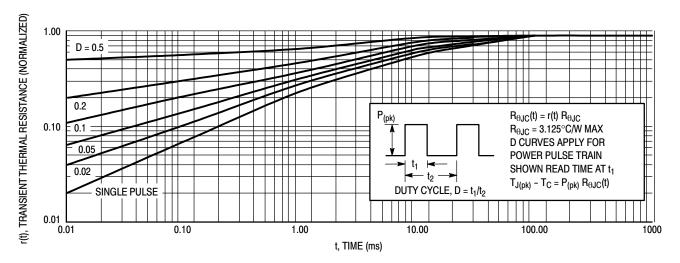


Figure 21. Typical Thermal Response for BUL146F

ORDERING INFORMATION

| Device | Package | Shipping |
|----------|--------------------------------|-----------------|
| BUL146G | TO-220AB (Pb-Free) | 50 Units / Rail |
| BUL146FG | TO-220 (Fullpack) (Pb-Free) | 50 Units / Rail |

TEST CONDITIONS FOR ISOLATION TESTS*

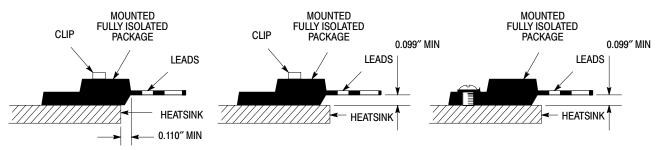


Figure 22a. Screw or Clip Mounting Position for Isolation Test Number 1

Figure 22b. Clip Mounting Position for Isolation Test Number 2

Figure 22c. Screw Mounting Position for Isolation Test Number 3

MOUNTING INFORMATION**

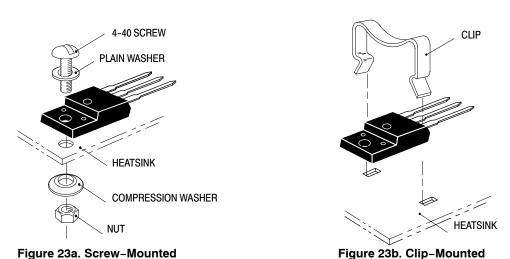


Figure 23. Typical Mounting Techniques for Isolated Package

Laboratory tests on a limited number of samples indicate, when using the screw and compression washer mounting technique, a screw torque of 6 to 8 in · lbs is sufficient to provide maximum power dissipation capability. The compression washer helps to maintain a constant pressure on the package over time and during large temperature excursions.

Destructive laboratory tests show that using a hex head 4–40 screw, without washers, and applying a torque in excess of 20 in · lbs will cause the plastic to crack around the mounting hole, resulting in a loss of isolation capability.

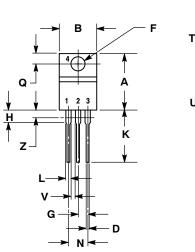
Additional tests on slotted 4–40 screws indicate that the screw slot fails between 15 to 20 in · lbs without adversely affecting the package. However, in order to positively ensure the package integrity of the fully isolated device, ON Semiconductor does not recommend exceeding 10 in · lbs of mounting torque under any mounting conditions.

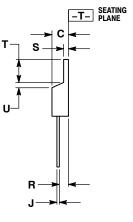
^{*}Measurement made between leads and heatsink with all leads shorted together

^{**} For more information about mounting power semiconductors see Application Note AN1040.

PACKAGE DIMENSIONS

TO-220AB CASE 221A-09 **ISSUE AF**





NOTES:

- NOTES:

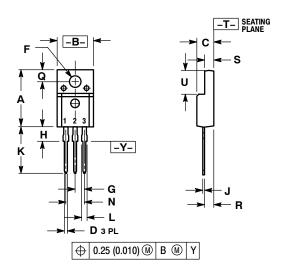
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: INCH.

 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

| | INC | HES | MILLIN | IETERS | | |
|---|---------|-------|--------|--------|--|--|
| DIM | MIN MAX | | MIN | MAX | | |
| Α | 0.570 | 0.620 | 14.48 | 15.75 | | |
| В | 0.380 | 0.405 | 9.66 | 10.28 | | |
| С | 0.160 | 0.190 | 4.07 | 4.82 | | |
| D | 0.025 | 0.035 | 0.64 | 0.88 | | |
| F | 0.142 | 0.161 | 3.61 | 4.09 | | |
| G | 0.095 | 0.105 | 2.42 | 2.66 | | |
| Н | 0.110 | 0.155 | 2.80 | 3.93 | | |
| J | 0.014 | 0.025 | 0.36 | 0.64 | | |
| K | 0.500 | 0.562 | 12.70 | 14.27 | | |
| L | 0.045 | 0.060 | 1.15 | 1.52 | | |
| N | 0.190 | 0.210 | 4.83 | 5.33 | | |
| Q | 0.100 | 0.120 | 2.54 | 3.04 | | |
| R | 0.080 | 0.110 | 2.04 | 2.79 | | |
| S | 0.045 | 0.055 | 1.15 | 1.39 | | |
| T | 0.235 | 0.255 | 5.97 | 6.47 | | |
| U | 0.000 | 0.050 | 0.00 | 1.27 | | |
| ٧ | 0.045 | | 1.15 | | | |
| Z | | 0.080 | | 2.04 | | |
| STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR | | | | | | |

TO-220 FULLPAK CASE 221D-03 ISSUE G



NOTES:

- VOIES: Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH 3. 2210-01 THRU 2210-02 OBSOLETE, NEW STANDARD 221D-03.

| | INC | HES | MILLIN | IETERS | |
|-----|-----------|-------|----------|--------|--|
| DIM | MIN | MAX | MIN | MAX | |
| Α | 0.625 | 0.635 | 15.88 | 16.12 | |
| В | 0.408 | 0.418 | 10.37 | 10.63 | |
| С | 0.180 | 0.190 | 4.57 | 4.83 | |
| D | 0.026 | 0.031 | 0.65 | 0.78 | |
| F | 0.116 | 0.119 | 2.95 | 3.02 | |
| G | 0.100 BSC | | 2.54 BSC | | |
| Н | 0.125 | 0.135 | 3.18 | 3.43 | |
| J | 0.018 | 0.025 | 0.45 | 0.63 | |
| K | 0.530 | 0.540 | 13.47 | 13.73 | |
| L | 0.048 | 0.053 | 1.23 | 1.36 | |
| N | 0.200 | BSC | 5.08 BSC | | |
| Q | 0.124 | 0.128 | 3.15 | 3.25 | |
| R | 0.099 | 0.103 | 2.51 | 2.62 | |
| S | 0.101 | 0.113 | 2.57 | 2.87 | |
| U | 0.238 | 0.258 | 6.06 | 6.56 | |

STYLE 2: PIN 1. BASE

- 2. COLLECTOR 3. EMITTER

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BUL146/D